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FORM PTO-1449 U.S. Department of Commerce Patent and Trademark Office					Attorney Docket Number:	Serial Number:	
LIST OF RELATED DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)					C0025A	10/661204	
					Applicant: Lail, et al.		
					Filing Date: 9/12/2003		Group: 2839
U. S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
HH	AA	US4420220	12/13/83	Dean et al.	350	96.23	11/4/80
HH	AB	US6654527	11/25/03	Sakabe et al.	385	114	10/15/02
HH	AC	US4078853	3/14/78	Kempf, et al.	350	96.23	2/25/76
HH	AD	US4979795	12/25/90	Mascarenhas	350	96.23	6/29/89
HH	AE	US5125063	6/23/92	Panuska, et al.	385	113	11/8/90
HH	AF	US5630003	5/13/97	Arroyo	385	113	11/30/95
HH	AG	US5668912	9/16/97	Keller	385	100	2/7/96
HH	AH	US6314224	11/6/01	Stevens, et al.	385	113	6/18/99
HH	AI	US6618526	9/9/03	Jackman, et al.	385	102	9/27/01
HH	AJ	US6714708	3/30/04	McAlpine, et al.	385	110	3/30/01
HH	AK	US6728451	4/27/04	Kordahi	385	100	1/17/01
HH	AL	US6847768	1/25/05	Lail, et al.	385	111	9/6/02
HH	AM	US6749446	6/15/04	Nechitailo	439	114	10/10/01
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation Yes No
HH	AQ	JP60-087307	5/17/85	Japan	G02B	6/44	Yes
HH	AR	EP1087247	4/9/00	Europe	G02B	6/44	Yes
HH	AS	DE2434280	7/17/74	Germany			Yes
	AT						
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AU						
	AV						
	AW						
EXAMINER /Hae Hyeon/					DATE CONSIDERED 02/02/2007		

*EXAMINER Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.